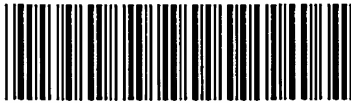


Search Notes

Application/Control No.

10/774,496

Examiner

Jack Chen

Applicant(s)/Patent under
Reexamination

IBA, YOSHIHISA

Art Unit

2813

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east (see attached printout for more details)	5/26/2006	JC